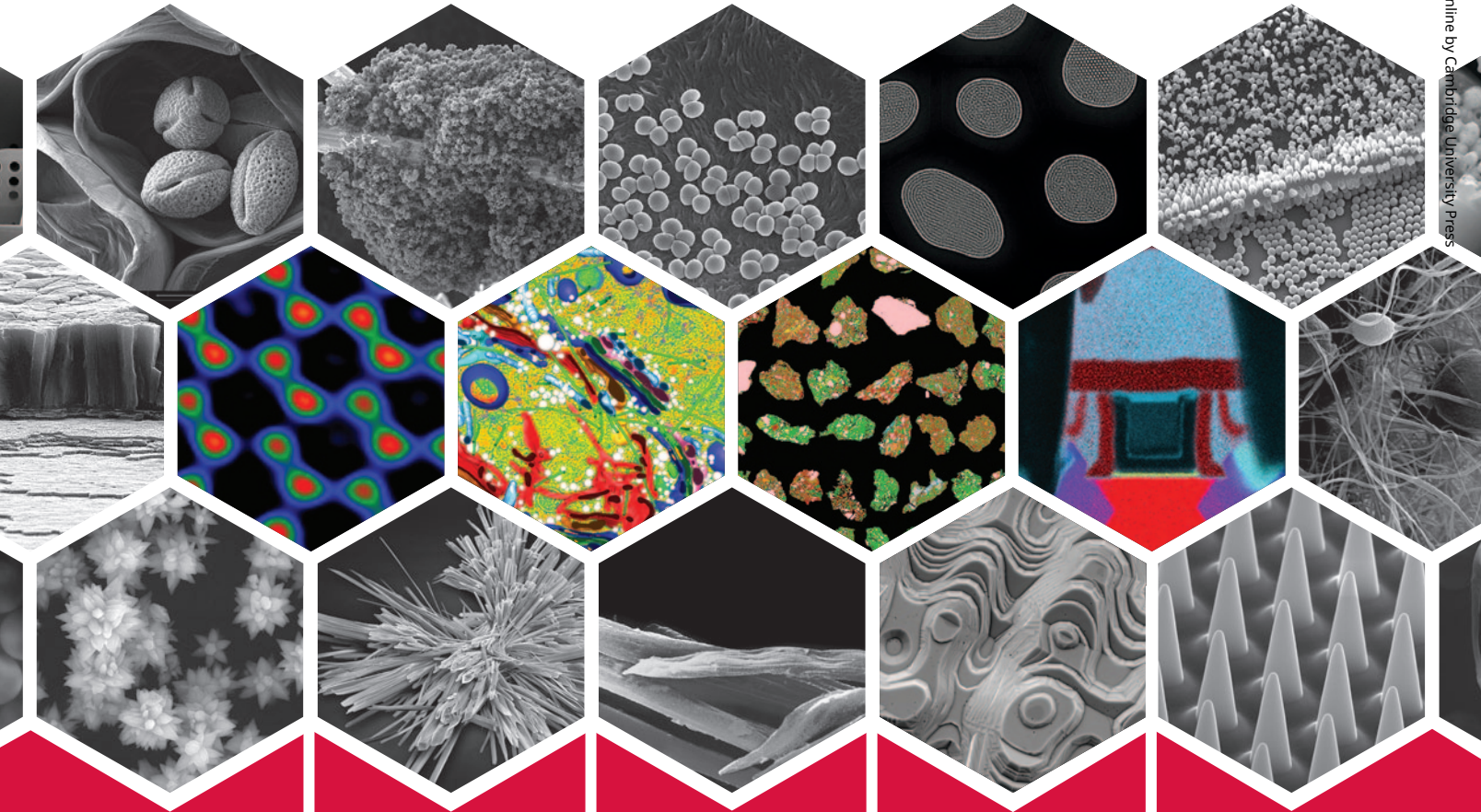




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Atomic resolution phase image of graphene Sample courtesy of N. Alem and A. Zettl, University of California, Berkeley. **Image slice from a high-resolution (~5nm) tomogram of the Golgi region in a pancreatic islet cell** Sample courtesy of N. Alem and A. Zettl, University of California, Berkeley • **600 x 600 pixel maps, fully quantified, of a 45 nm PMOS transistor structure** Courtesy of D. Klenov, FEI NanoPort, The Netherlands • **Drill cuttings from a CO2 injection well** Courtesy CO2CRC, Australia

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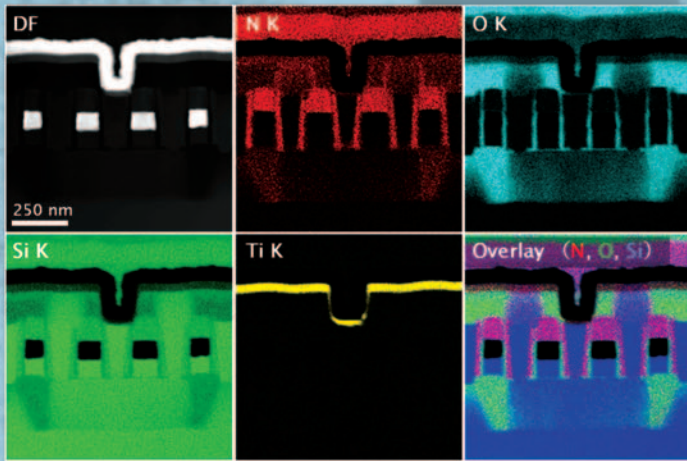
0.98sr 100mm²

- Exponentially enhances elemental mapping for nano-area analysis TEM
- Automatic retractable design



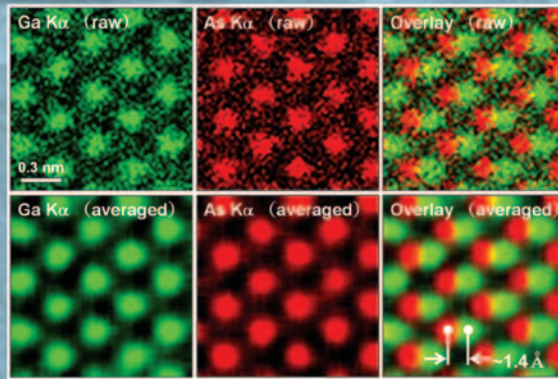
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